LISTING OF CLAIMS

1. (Original) An image sensor with matrix readout including a matrix of elementary photodetectors (P) connected through at least a bus (Bpel) to a remote integrand) converting the signal of each elementary photodetector into a voltage, characterized in that includes, between the end of the bus and the input of the integrator, an impedar ce matching device (D) delivering at its output, during the time required for converting a photodetector signal, a variation of charge which corresponds to an affine function of the charge presents the input of said matching device, wherein this variation of charge is determined by:

$$\int_{t=0}^{t=T_{CODY}} \overline{linj(t)}.dt = \int_{t=0}^{t=T_{CODY}} Iint(t).dt$$

wherein Iinj is the instantaneous current of the bus, injected at the input of the impedance matching device, Iint is the instantaneous current at the input of the integrator and Tconvisthe conversion time.

- 2. (Original) The image sensor according to claim 1, characterized in that the impedance matching device (V) has a low output capacitance.
- 3. (Previously presented) The image sensor according to claim 1, characterized in that the impedance matching device is connected as close as possible to the input of the integrator.
- 4. (Previously presented) The image sensor according to claim 1, characterized in that the impedance matching device includes a common-gate TMOS transistor (T)

mounted on the input of the integrator.

- 5. (Previously presented) The image sensor according to claim 1, characterized in that the impedance matching device includes a common-gate TMOS transfor (T) associated with a feedback amplifier (G).
- 6. (Original) The image sensor according to claim 1, characterized in that the impedance matching device includes two transistors (T1, T2) and two voltage sources (V1, V2) mounted as a current mirror.
- 7. (Previously presented) The image sensor according to claim 2, characterized in that the impedance matching device is connected as close as possible to the input of the integrator.
- 8. (Previously presented) The image sensor according to claim 3, characterized in that the impedance matching device includes a common-gate TMOS transistor (T) mounted on the input of the integrator.
- 9. (Previously presented) The image sensor according to claim 4, characterized in that the impedance matching device includes a common-gate TMOS transistor (T) associated with a feedback aimplifier (G).